



8. The method of claim 1, wherein said analysis means comprises an algorithm selected from the group consisting of Markov models, hidden Markov models, partial least squares and principal component analysis.
9. The method of claim 7 or 8, wherein the data set comprises information from issued patents or patent applications.
10. The method of claim 7 or 8, wherein said analysis means utilizes one or more of the group consisting of genetic algorithms, Bayesian learning, neural networks, Markov models, hidden Markov models, co-word analysis, co-citation analysis, partial least square, or principle component analysis.
11. The method of claim 1, wherein the method further includes the step of formatting at least a portion of the data set which is not in a standard format into a standard format prior to utilizing the analysis means.
12. The method of claim 1, wherein said analysis means utilizes algorithms selected from the group consisting of co-citation analysis, co-word analysis, genetic algorithms, Bayesian learning, neural networks, Markov models, hidden Markov models, partial least squares, or principal component analysis, to create a visually displayable index to a selected set of documents.
13. An expert system for analysis of a collection of documents, comprising:
- a) means for selecting a data set for analysis from the collection of documents;

b) means for selecting at least one analysis algorithm for said data set based on the structure of said data set; and

c) means for utilizing said at least one analysis algorithm to perform an analysis of said data set to produce a result comprising relationships among the documents in said data set.

14. The expert systems as claimed in claim 13, wherein the result comprises an index.

15. The expert systems as claimed in claim 13, wherein the result comprises a graphical representation.

16. The expert systems as claimed in claim 13, wherein the result is in a visual index form suitable for display or further analysis.

17. The expert systems as claimed in claim 13, wherein said analysis means includes means to identify and display patterns in patenting activity, patterns in scientific research, patterns in commercial activity or patterns in popular interest in an area that can affect business or technology decisions.


18. The expert systems as claimed in claim 13, wherein said analysis means comprises an algorithm capable of bibliographic analysis.

19. The expert systems as claimed in claim 13, wherein said analysis means comprises an algorithm selected from the group consisting of co-occurrence analysis, co-word analysis and co-citation analysis.

20. The expert systems as claimed in claim 13, wherein said analysis means comprises an algorithm selected from the group consisting of Markov

models, hidden Markov models, partial least squares and principal component analysis.

21. The expert systems as claimed in claim 13, wherein the data set comprises information from issued patents or patent applications.
22. The expert systems as claimed in claim 13, wherein said analysis means utilizes one or more of the group consisting of genetic algorithms, Bayesian learning, neural networks, Markov models, hidden Markov models, co-word analysis, co-citation analysis, partial least square, or principle component analysis.
23. The expert systems as claimed in claim 13, wherein the method further includes the step of formatting at least a portion of the data set which is not in a standard format into a standard format prior to utilizing the analysis means.
24. The expert systems as claimed in claim 13, wherein said analysis means utilizes algorithms selected from the group consisting of co-word, co-citation analysis, genetic algorithms, Bayesian learning, neural networks, Markov models, hidden Markov models, partial least squares, or principal component analysis, to create a visually displayable index to a selected set of documents.



## References Cited Herein

1. Liu, Shang-jyh and Shyu, Joenson. " Strategic Planning for Technology Development with Patent Analysis," Int. J. Technology Management 13 (5/6): 661-680, 1997.
2. Schmiemann, Manfred. "The link between R&D, Inventions, and Innovations in Europe," World Patent Information. 21:43-45, 1997.
3. Collada, V. Parajon. "Innovation and Patents," World Patent Information. 21:5-7, 1999.
4. Dusasauge, P.; Hart, S. (1992) Strategic Technology Management. New York: John Wiley.
5. Narin, Francis, Carpenter, Mark P., Woolf, Patricia. "Technological Performance Assessment Based on Patents and Patent Citations," IEEE Transactions 31 (N4), 172-183, 1984.
6. Kuhn, Thomas S. *The Structure of Scientific Revolutions*, 2<sup>nd</sup> Ed., The University of Chicago Press, 1970.

0922700022660

7. King, Jean. "A Review Of Bibliometric And Other Science Indicators And Their Role In Research Evaluation," Journal of Information Sciences. 13:261-275, 1987.
- 5 8. Osareh, Farideh. "Bibliometrics, Citation analysis and Co-Citation analysis: A Review of the Literature," Libri 46:149-158, 1996.
9. Kostoff, Ronald N. " Science and Technology Roadmaps." Office of Naval Research. 800 Quincy St., Arlington, VA 22217.  
10 <http://www.dtic.mil/dtic/kostoff/Mapweb2V.htm>
10. Okubo, Yoshiko. "Bibliometric, Indicators and Anslsis of Research Systems: Methods and Examples," OCDE/GED(97)41.
- 15 11. Breitzman, Anthony. "Accessing an Industyr's R&D Focus Rapidly: A Case Study Using Data-Driven Categorization in a Consumer Products Area," Competitive Intelligence Review, 11(1): 58-64, 2000.
13. Kostoff, Ronald. "Database Tomography for Technical Intelligence:  
20 analysis of the Research Impact Assessment Literature," Competitive Intelligence Review. 8(2), 63-79, 1997.

13. Engelsmann, E.C. and van Raan, A.F.J. " A Patent-Based Cartography of Technology," Research Policy. 23:1-26, 1994.

14. Ashton,B.W., Klavans,R.A. (1997) Keeping Abreast of Science and  
5 Technology: Technical Intelligence for Business, Columbus: Battelle  
Press.

15. Moguee, Mary Ellen. "Patent Analysis Methods in Support of Licensing."  
Presented at the Technology Transfer Society Annual Conference. July  
10 22, 1997. <http://www.mogee.com/reprts/methods.htm>.

10/20/97 00:22:66